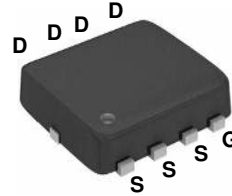
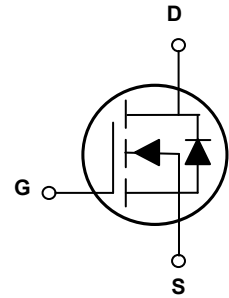


### Main Product Characteristics

$V_{(BR)DSS}$	100V
$R_{DS(ON)}$	13.6m $\Omega$
$I_D$	48A



PPAK3X3



Schematic Diagram

### Features and Benefits

- Advanced MOSFET processtechnology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery

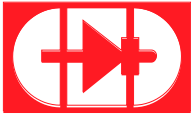


### Description

The GSFN0982 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supply and a wide variety of other applications.

### Absolute Maximum Ratings ( $T_C=25^{\circ}\text{C}$ unless otherwise specified)

Parameter	Symbol	Max.	Unit
Drain-Source Voltage	$V_{DS}$	100	V
Gate-Source Voltage	$V_{GS}$	+20/-12	V
Drain Current-Continuous( $T_C=25^{\circ}\text{C}$ )	$I_D$	48	A
Drain Current-Continuous( $T_C=100^{\circ}\text{C}$ )		30	
Drain Current-Pulsed <sup>1</sup>	$I_{DM}$	192	A
Single Pulse Avalanche Energy <sup>2</sup>	$E_{AS}$	115	mJ
Single Pulse Avalanche Current <sup>2</sup>	$I_{AS}$	48	A
Power Dissipation( $T_C=25^{\circ}\text{C}$ )	$P_D$	61	W
Power Dissipation-Derate above 25 $^{\circ}\text{C}$		0.49	
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62	$^{\circ}\text{C}/\text{W}$
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	2.04	$^{\circ}\text{C}/\text{W}$
Storage Temperature Range	$T_{STG}$	-50 To +150	$^{\circ}\text{C}$
Operating Junction Temperature Range	$T_J$	-50 To +150	$^{\circ}\text{C}$

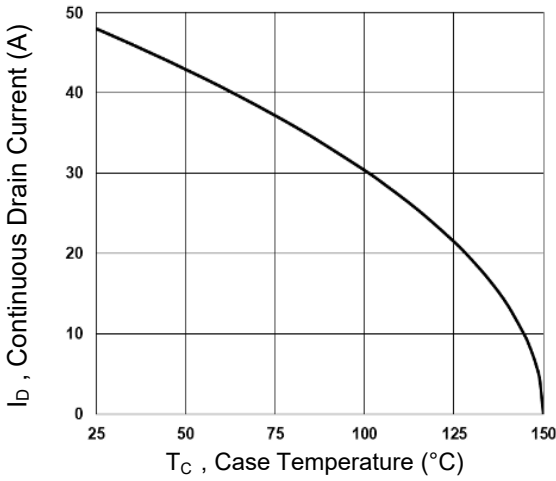

**Electrical Characteristics** ( $T_J=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>On/Off Characteristics</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	100	-	-	V
$BV_{DSS}$ Temperature Coefficient	$\Delta BV_{DSS}/\Delta T_J$	Reference to $25^\circ\text{C}$ , $I_D=1mA$	-	0.06	-	$V/^\circ\text{C}$
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS}=100V, V_{GS}=0V,$ $T_J=25^\circ\text{C}$	-	-	1	$\mu A$
		$V_{DS}=80V, V_{GS}=0V,$ $T_J=125^\circ\text{C}$	-	-	10	$\mu A$
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS}=+20V, V_{DS}=0V$	-	-	100	nA
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=20A$	-	11.3	13.6	m $\Omega$
		$V_{GS}=10V, I_D=20A,$ $T_J=125^\circ\text{C}$	-	19	-	
		$V_{GS}=4.5V, I_D=15A$	-	16.7	22	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	1	1.5	2.5	V
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}$		-	-5.1	-	$mV/^\circ\text{C}$
Forward Transconductance	$g_{fs}$	$V_{DS}=10V, I_D=3A$	-	8	-	S
<b>Dynamic and Switching Characteristics</b>						
Total Gate Charge <sup>3,4</sup>	$Q_g$	$V_{DS}=50V, I_D=10A,$ $V_{GS}=10V$	-	27.8	55	nC
Gate-Source Charge <sup>3,4</sup>	$Q_{gs}$		-	3.5	7	
Gate-Drain Charge <sup>3,4</sup>	$Q_{gd}$		-	8.8	17	
Turn-On Delay Time <sup>3,4</sup>	$t_{d(on)}$	$V_{DD}=50V, R_G=6\Omega,$ $V_{GS}=10V, I_D=1A$	-	14.2	28	nS
Rise Time <sup>3,4</sup>	$t_r$		-	20.8	42	
Turn-Off Delay Time <sup>3,4</sup>	$t_{d(off)}$		-	42	84	
Fall Time <sup>3,4</sup>	$t_f$		-	30	60	
Input Capacitance	$C_{iss}$	$V_{DS}=50V, V_{GS}=0V,$ $F=1MHz$	-	1640	3280	pF
Output Capacitance	$C_{oss}$		-	240	480	
Reverse Transfer Capacitance	$C_{rss}$		-	4	10	
Gate Resistance	$R_g$	$V_{GS}=0V, V_{DS}=0V,$ $F=1MHz$	-	1.14	-	$\Omega$
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
Continuous Source Current	$I_S$	$V_G=V_D=0V,$	-	-	48	A
Pulsed Source Current	$I_{SM}$	Force Current	-	-	96	A
Diode Forward Voltage	$V_{SD}$	$V_{GS}=0V, I_S=1A,$ $T_J=25^\circ\text{C}$	-	-	1	V
Reverse Recovery Time <sup>3</sup>	$t_{rr}$	$I_S=10A,$ $di/dt=100A/\mu s,$	-	43.5	-	nS
Reverse Recovery Charge <sup>3</sup>	$Q_{rr}$	$T_J=25^\circ\text{C}$	-	59.6	-	nC

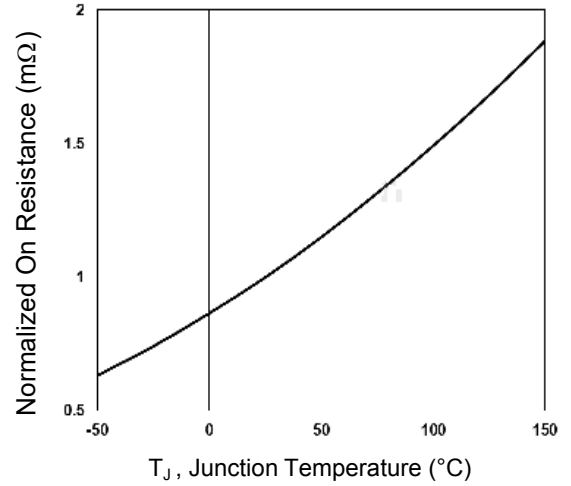
Note:

1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
2.  $V_{DD}=50V, V_{GS}=10V, L=0.1mH, I_{AS}=48A, R_G=25\Omega,$  Starting  $T_J=25^\circ\text{C}$
3. The data tested by pulsed, pulse width  $\leq 300\mu s,$  duty cycle  $\leq 2\%$ .
4. Essentially independent of operating temperature.

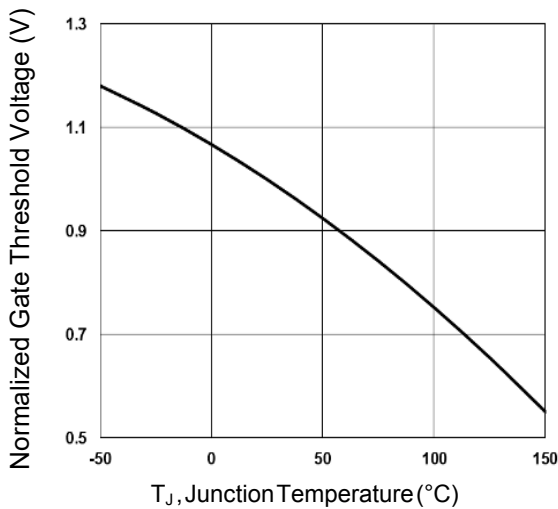
**Typical Electrical and Thermal Characteristic Curves**



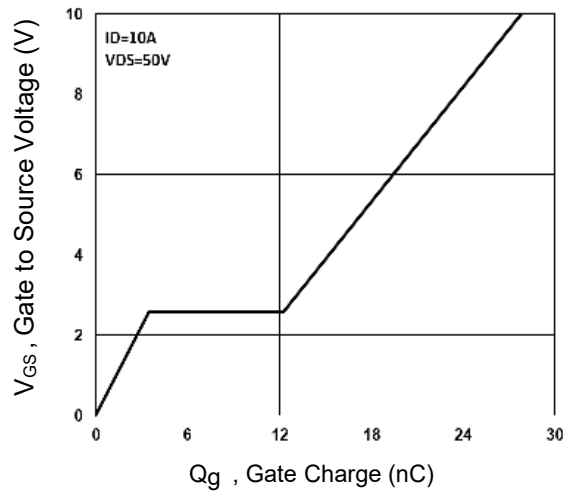
**Fig.1 Continuous Drain Current vs.  $T_C$**



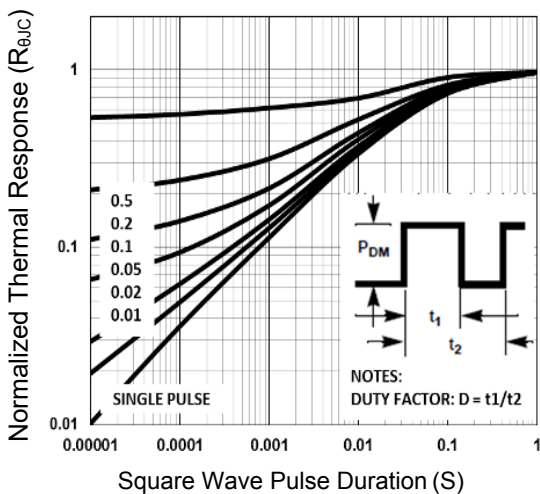
**Fig.2 Normalized  $R_{DS(ON)}$  vs.  $T_J$**



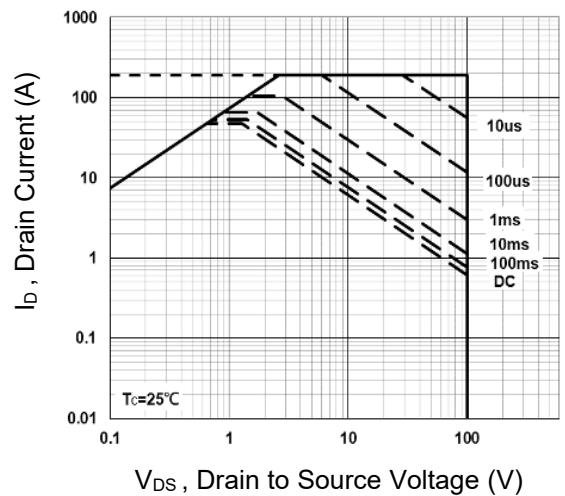
**Fig.3 Normalized  $V_{th}$  vs.  $T_J$**



**Fig.4 Gate Charge Waveform**

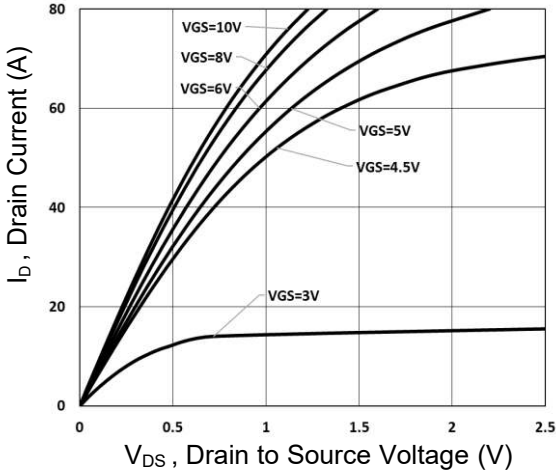


**Fig.5 Normalized Transient Impedance**

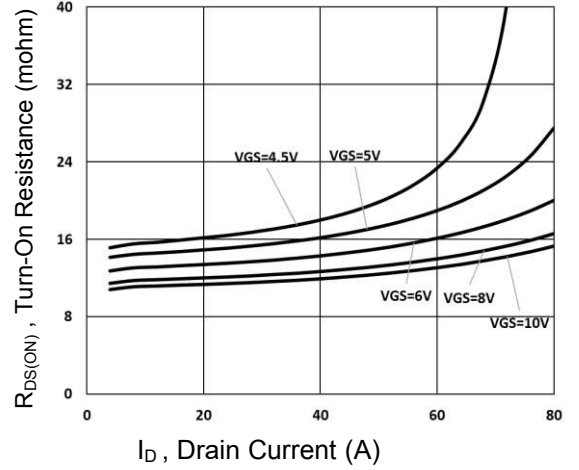


**Fig.6 Maximum Safe Operation Area**

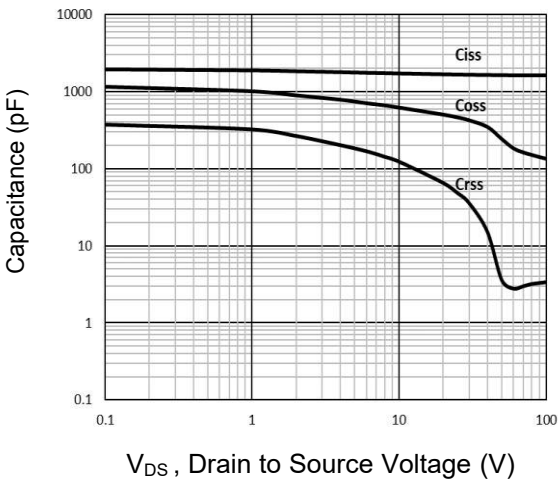
**Typical Electrical and Thermal Characteristic Curves**



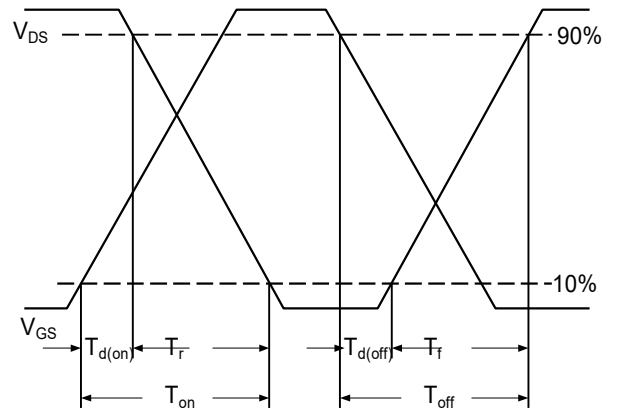
**Fig.7 Typical Output Characteristics**



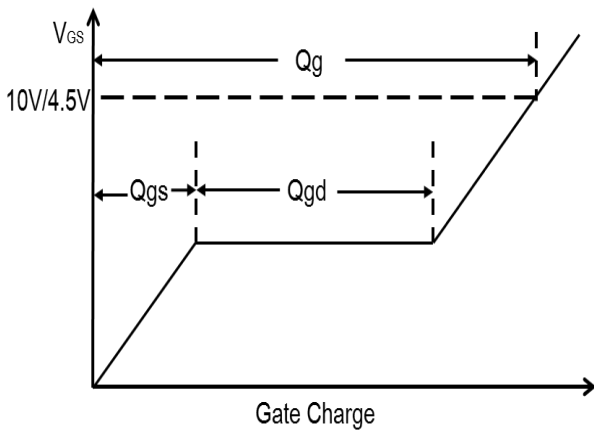
**Fig.8 Turn-On Resistance vs.  $I_D$**



**Fig.9 Capacitance Characteristics**



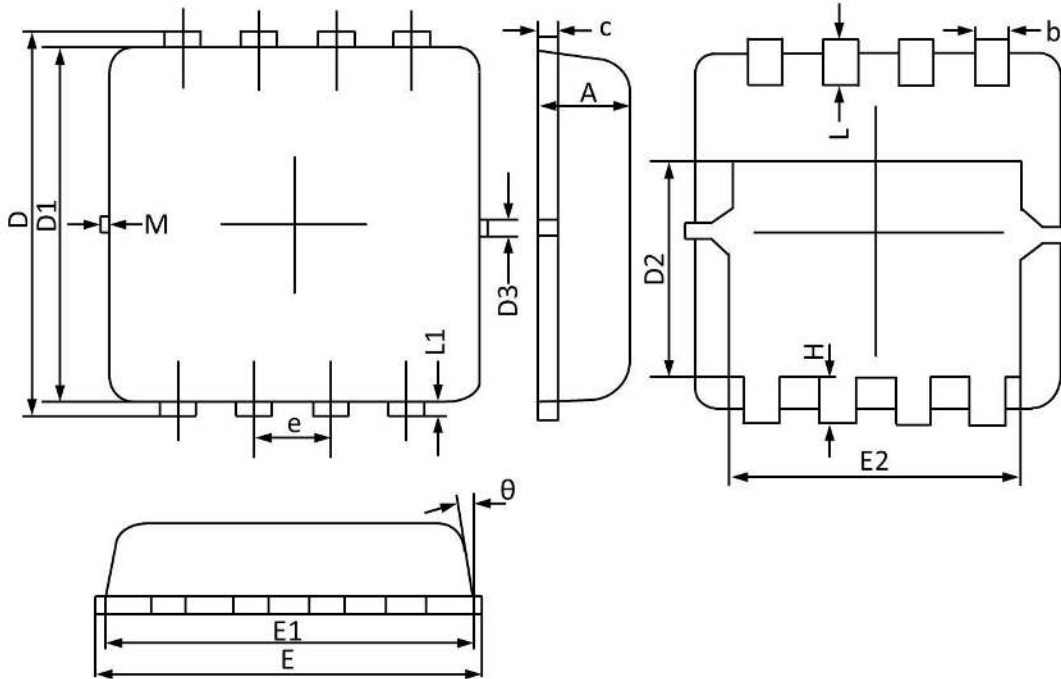
**Fig.10 Switching Time Waveform**



**Fig. 11 Gate Charge Waveform**

**Package Outline Dimensions**

**PPAK3X3**



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	0.700	0.800	0.028	0.031
b	0.250	0.350	0.010	0.013
c	0.100	0.250	0.004	0.009
D	3.250	3.450	0.128	0.135
D1	3.000	3.200	0.119	0.125
D2	1.780	1.980	0.070	0.077
D3	0.130 REF		0.005 REF	
E	3.200	3.400	0.126	0.133
E1	3.000	3.200	0.119	0.125
E2	2.390	2.590	0.094	0.102
e	0.650 BSC		0.026 BSC	
H	0.300	0.500	0.011	0.019
L	0.300	0.500	0.011	0.019
L1	0.130 REF		0.005 REF	
theta	0°	12°	0°	12°
M	0.150 REF		0.006 REF	